

### **BUH1215**

# HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

- STMicroelectronics PREFERRED SALESTYPE
- HIGH VOLTAGE CAPABILITY
- VERY HIGH SWITCHING SPEED

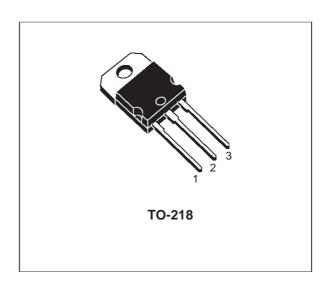
#### **APPLICATIONS:**

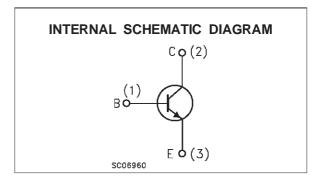
 HORIZONTAL DEFLECTION FOR COLOUR TV AND MONITORS

#### **DESCRIPTION**

The BUH1215 is manufactured using Multiepitaxial Mesa technology for cost-effective high performance and uses a Hollow Emitter structure to enhance switching speeds.

The BUH series is designed for use in horizontal deflection circuits in televisions and monitors.





#### **ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter	Value	Unit
V <sub>CBO</sub>	Collector-Base Voltage (I <sub>E</sub> = 0)	1500	V
V <sub>CEO</sub>	Collector-Emitter Voltage (I <sub>B</sub> = 0)	700	V
V <sub>EBO</sub>	Emitter-Base Voltage (I <sub>C</sub> = 0)	10	V
Ic	Collector Current	16	Α
I <sub>CM</sub>	Collector Peak Current (t <sub>p</sub> < 5 ms)	22	Α
I <sub>B</sub>	Base Current	9	Α
I <sub>BM</sub>	Base Peak Current (t <sub>p</sub> < 5 ms)	12	Α
P <sub>tot</sub>	Total Dissipation at T <sub>c</sub> = 25 °C	200	W
T <sub>stg</sub>	Storage Temperature	-65 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

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#### **BUH1215**

#### THERMAL DATA

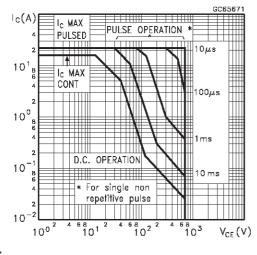
R <sub>thj-case</sub> Thermal Resistance Junction-case	Max 0.63	°C/W
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#### **ELECTRICAL CHARACTERISTICS** (T<sub>case</sub> = 25 °C unless otherwise specified)

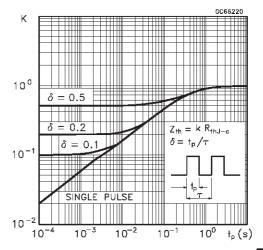
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I <sub>CES</sub>	Collector Cut-off Current (V <sub>BE</sub> = 0)	V <sub>CE</sub> = 1500 V V <sub>CE</sub> = 1500 V T <sub>j</sub> = 125 °C			0.2 2	mA mA
I <sub>EBO</sub>	Emitter Cut-off Current (I <sub>C</sub> = 0)	V <sub>EB</sub> = 5 V			100	μΑ
V <sub>CEO(sus)</sub>	Collector-Emitter Sustaining Voltage	I <sub>C</sub> = 100 mA	700			V
V <sub>EBO</sub>	Emitter-Base Voltage (I <sub>C</sub> = 0)	I <sub>E</sub> = 10 mA	10			V
V <sub>CE(sat)</sub> *	Collector-Emitter Saturation Voltage	I <sub>C</sub> = 12 A I <sub>B</sub> = 2.4 A			1.5	V
V <sub>BE(sat)</sub> *	Base-Emitter Saturation Voltage	I <sub>C</sub> = 12 A I <sub>B</sub> = 2.4 A			1.5	V
h <sub>FE</sub> *	DC Current Gain	$I_{C} = 12 \text{ A}$ $V_{CE} = 5 \text{ V}$ $I_{C} = 12 \text{ A}$ $V_{CE} = 5 \text{ V}$ $T_{j} = 100  ^{\circ}\text{C}$	7 5	10	14	
t <sub>s</sub>	RESISTIVE LOAD Storage Time Fall Time	$V_{CC} = 400 \text{ V}$ $I_{C} = 12 \text{ A}$ $I_{B1} = 2 \text{ A}$ $I_{B2} = -6 \text{ A}$		1.5 110		μs ns
t <sub>s</sub>	INDUCTIVE LOAD Storage Time Fall Time			4 220		μs ns
t <sub>s</sub>	INDUCTIVE LOAD Storage Time Fall Time	$\begin{aligned} &I_{C}=6 \text{ A} & f=64 \text{ KHz} \\ &I_{B1}=1 \text{ A} & V_{BE(off)}=-2 \text{ A} \\ &V_{ceflyback}=1200 \text{ sin}\bigg(\frac{\pi}{5} \cdot 10^6\bigg) t & V \end{aligned}$		3.5 180		μs ns

<sup>\*</sup> Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %

#### Safe Operating Area

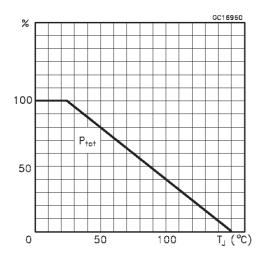


#### Thermal Impedance

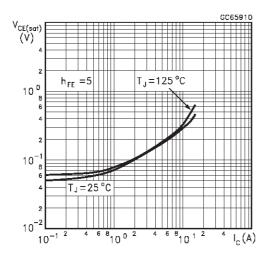


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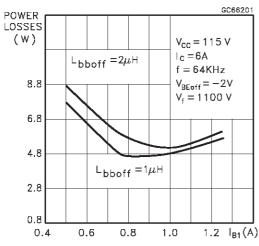
#### **Derating Curve**



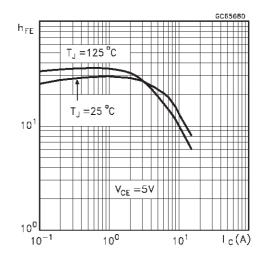
#### Collector Emitter Saturation Voltage



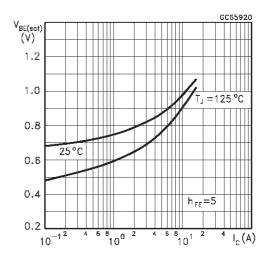
#### Power Losses at 64 KHz



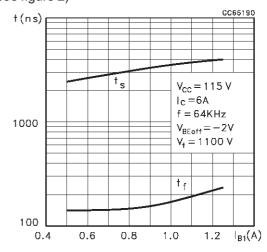
#### DC Current Gain



#### Base Emitter Saturation Voltage

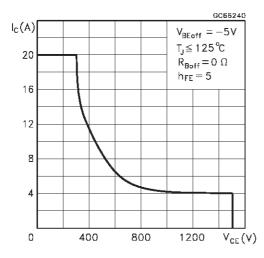


# Switching Time Inductive Load at 64 KHz (see figure 2)



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#### Reverse Biased SOA



#### **BASE DRIVE INFORMATION**

In order to saturate the power switch and reduce conduction losses, adequate direct base current  $I_{B1}$  has to be provided for the lowest gain  $h_{FE}$  at 100  $^{\circ}$ C (line scan phase). On the other hand, negative base current  $I_{B2}$  must be provided the transistor to turn off (retrace phase).

Most of the dissipation, especially in the deflection application, occurs at switch-off so it is essential to determine the value of  $I_{B2}$  which minimizes power losses, fall time  $t_f$  and, consequently,  $T_j$ . A new set of curves have been defined to give total power losses,  $t_s$  and  $t_f$  as a function of  $I_{B1}$  at 64 KHz scanning frequencies for

choosing the optimum negative drive. The test circuit is illustrated in figure 1.

The values of L and C are calculated from the following equations:

$$\frac{1}{2}L(I_C)^2 = \frac{1}{2}C(V_{CEfly})^2$$
$$\omega = 2\pi f = \frac{1}{\sqrt{LC}}$$

Where  $I_C$  = operating collector current,  $V_{CEfly}$ = flyback voltage, f= frequency of oscillation during retrace.

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Figure 1: Inductive Load Switching Test Circuits.

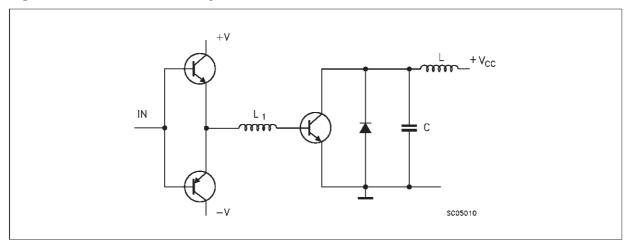
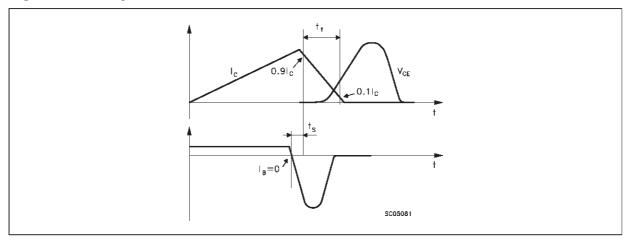
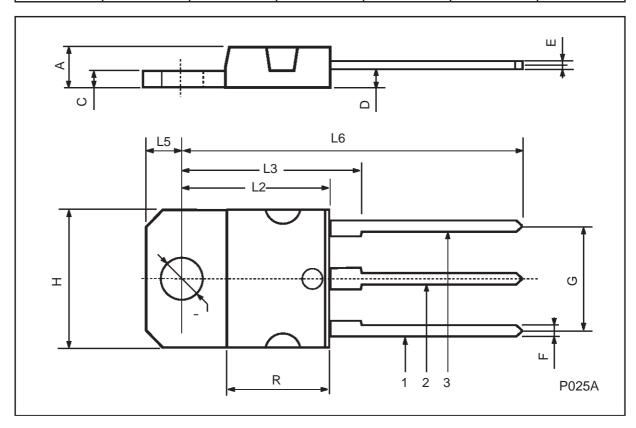


Figure 2: Switching Waveforms in a Deflection Circuit



## TO-218 (SOT-93) MECHANICAL DATA

DIM.		mm			inch	
Diwi.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	4.7		4.9	0.185		0.193
С	1.17		1.37	0.046		0.054
D		2.5			0.098	
Е	0.5		0.78	0.019		0.030
F	1.1		1.3	0.043		0.051
G	10.8		11.1	0.425		0.437
Н	14.7		15.2	0.578		0.598
L2	_		16.2	-		0.637
L3		18			0.708	
L5	3.95		4.15	0.155		0.163
L6		31			1.220	
R	_		12.2	1		0.480
Ø	4		4.1	0.157		0.161



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